

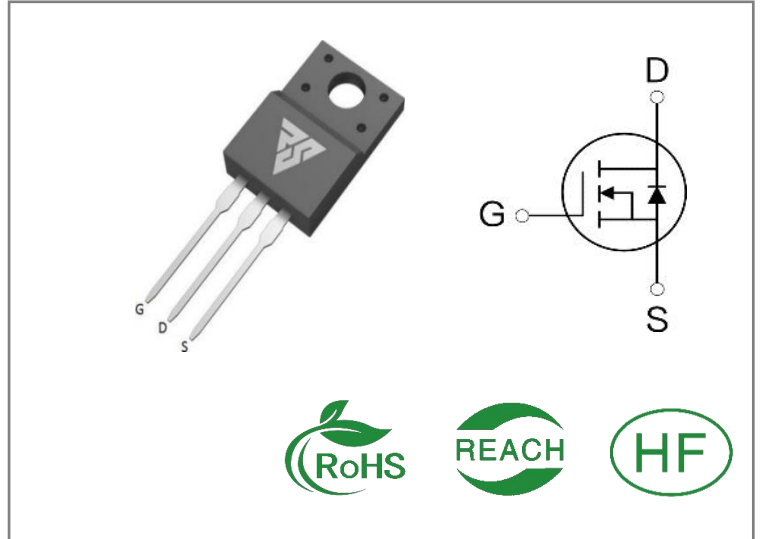
<b>ID</b>	<b>R<sub>Ds(ON)</sub>(Typ)</b>	<b>VDSS</b>
20A	0.35Ω	650V

**Applications:**

- Switch Mode Power Supply(SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)

**Features:**

- Fast switching speed
- 100% avalanche tested
- Improved dv/dt capability


**Ordering Information**

Part Number	Package	Marking	Packing	Qty.
RS20N65F	T0-220F	RS20N65F	Tube	50 PCS

**Absolute Maximum Ratings** Tc= 25°C unless otherwise specified

Symbol	Parameter	RS20N65F	Units
VDSS	Drain-to-Source Voltage	650	V
ID	Continuous Drain Current TC=25°C	20	A
IDM	Pulsed Drain Current (Note*1)	80	
PD	Power Dissipation	62	W
VGS	Gate- to- Source Voltage	±30	V
EAS	Single Pulse Avalanche Energy L = 10mH, VDD = 50V, RG = 25Ω	605	mJ
TL TPKG	Maximum Temperature for Soldering	300 260	°C
	Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds		
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

\* Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the“ Absolute Maximum Ratings” Table may cause permanent damage to the device.

**Thermal Resistance**

Symbol	Parameter	RS20N65F	Units	Test Conditions
R $\theta$ JC	Junction-to-Case	2.01	°C / W	Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 °C
R $\theta$ JA	Junction-to-Ambient	39.7		1 cubic foot chamber, free air.

**OFF Characteristics** T<sub>J</sub>= 25°C unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
BVDSS	Drain- to- source Breakdown Voltage	650	--	--	V	VGS=0V, ID=250μA
IDSS	Drain- to- Source Leakage Current	--	--	1	μA	VDS=650V, VGS=0V
IGSS	Gate- to- Source Forward Leakage	--	--	100	nA	VGS=30V , VDS=0V
	Gate- to- Source Reverse Leakage	--	--	-100		VGS=-30V , VDS=0V

**ON Characteristics** T<sub>J</sub>=25°C unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
RDS(on)	Static Drain- to- Source On-Resistance(Note*2)	--	0.35	0.45	Ω	VGS=10V, ID=10A
VGS(TH)	Gate Threshold Voltage	3	--	4	V	VGS=VDS, ID=250μA

**Resistive Switching Characteristics** Essentially independent of operating temperature

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
td(ON)	Turn- on Delay Time	--	54	--	nS	VDS=325V ID=20A RG=25Ω
trise	Rise Time	--	48.4	--		
td(OFF)	Turn- OFF Delay Time	--	301	--		
tfall	Fall Time	--	85	--		

**Dynamic Characteristics** Essentially independent of operating temperature

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
Ciss	Input Capacitance	--	2071	--	pF	VGS=0V VDS=25V f=1.0MHz
Coss	Output Capacitance	--	249.5	--		
Crss	Reverse Transfer Capacitance	--	24.8	--		
Qg	Total Gate Charge	--	80	--	nC	VDS=520V ID=20A VGS=10V
Qgs	Gate- to- Source Charge	--	12	--		
Qgd	Gate-to-Drain(" Miller") Charge	--	34	--		

**Source- Drain Diode Characteristics**

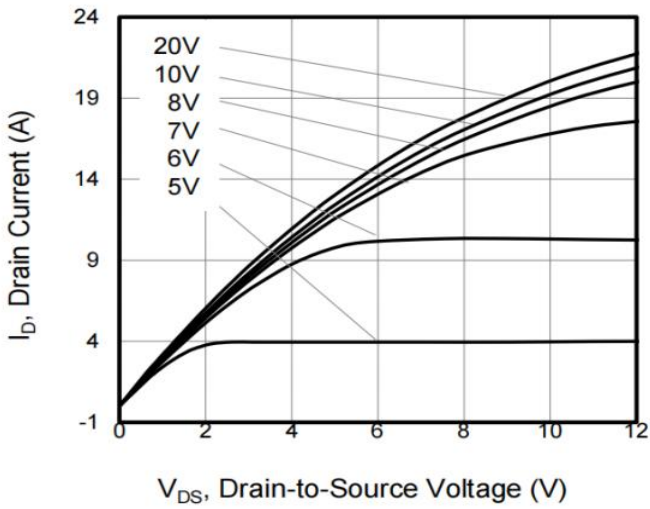
Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
IS	Continuous Source Current	--	--	20	A	Integral pn- diode in MOSFET
ISM	Maximum Pulsed Current	--	--	80	A	
VSD	Diode Forward Voltage	--	--	1.4	V	IS=10A,VGS=0V
trr	Reverse Recovery Time	--	440	--	nS	VGS=0V IS=20A,di/dt=100 A/μs
Qrr	Reverse Recovery Charge	--	7.9	--	μC	

**Notes:**

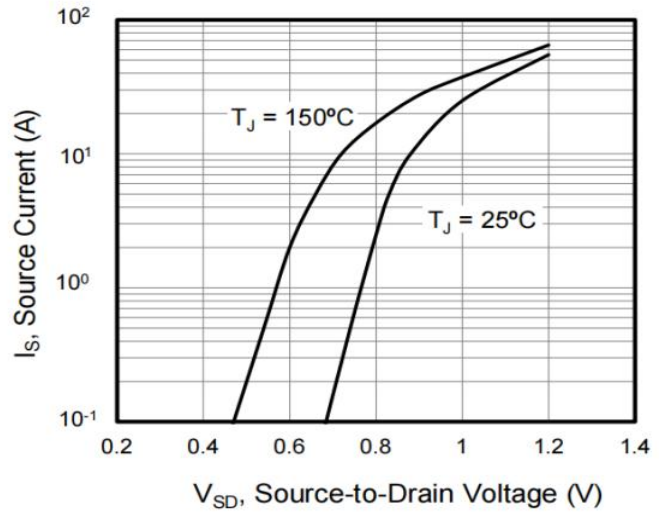
- \* 1. Repetitive rating, pulse width limited by maximum junction temperature.
- \* 2. Pulse Test: Pulse width ≤ 300μs, Duty Cycle ≤ 1%

**Typical Feature Curve**

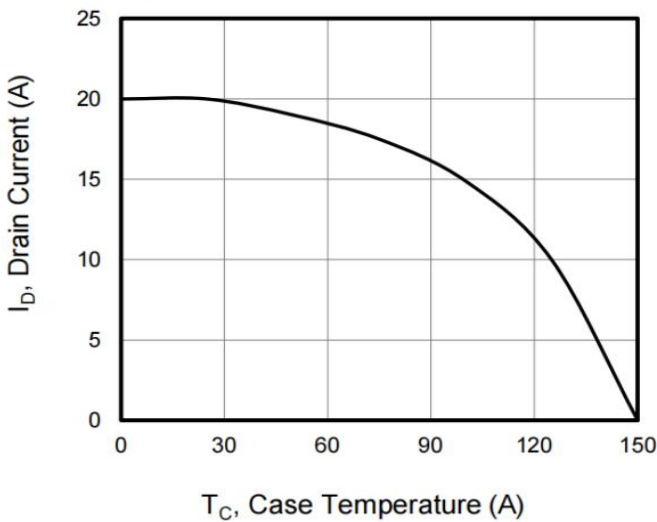
**Figure 1. Output Characteristics ( $T_J = 25^\circ\text{C}$ )**



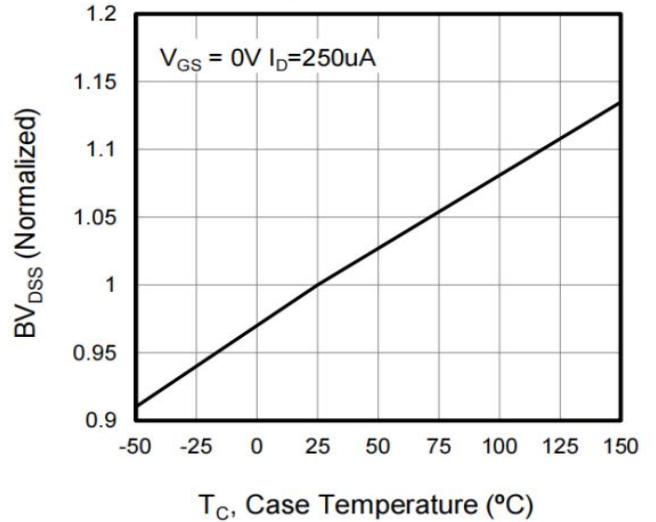
**Figure 2. Body Diode Forward Voltage**



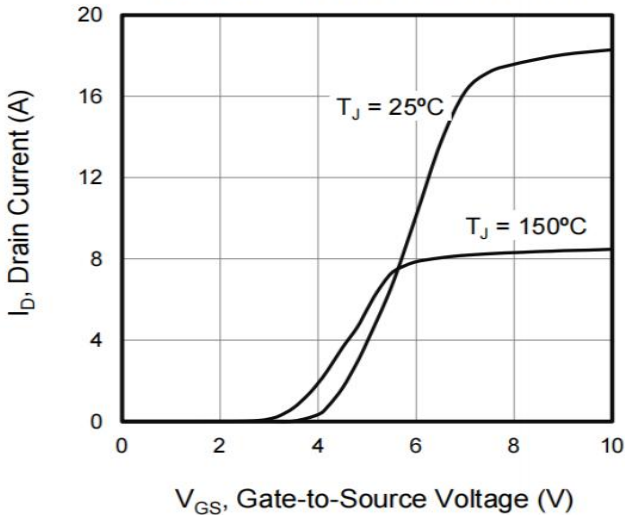
**Figure 3. Drain Current vs. Temperature**



**Figure 4.  $BV_{DSS}$  Variation vs. Temperature**



**Figure 5. Transfer Characteristics**



**Figure 6. On-Resistance vs. Temperature**

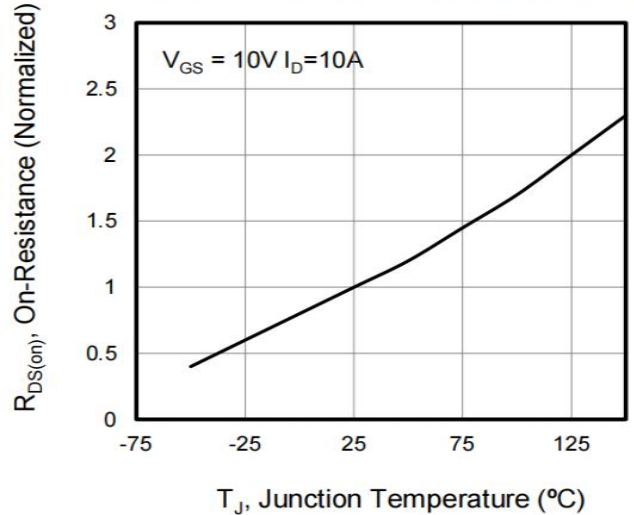


Figure 7. Capacitance

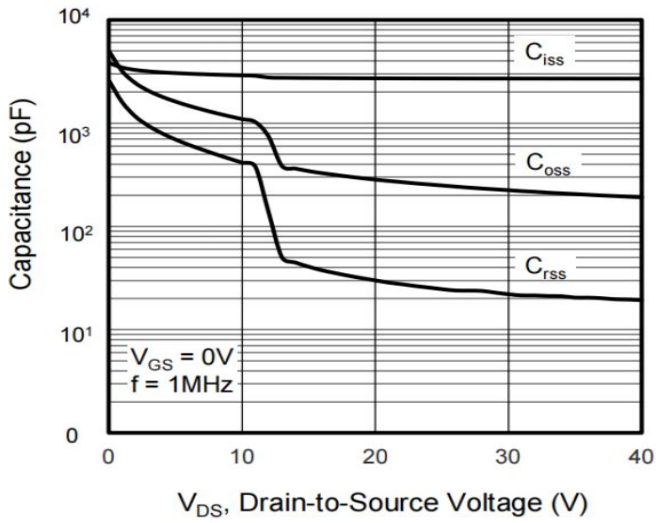


Figure 8. Gate Charge

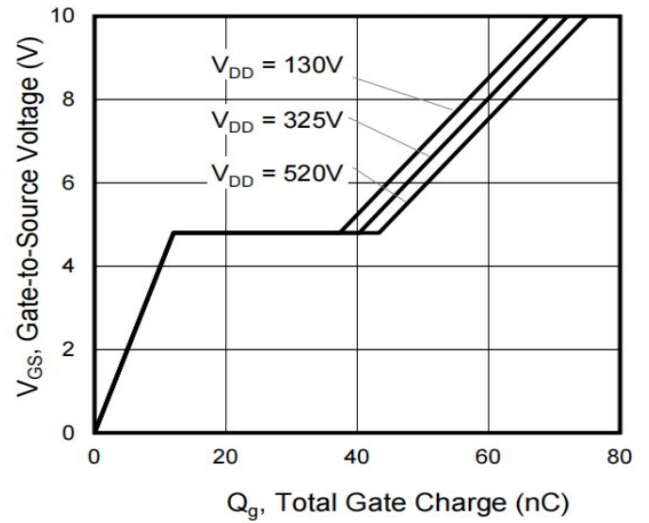
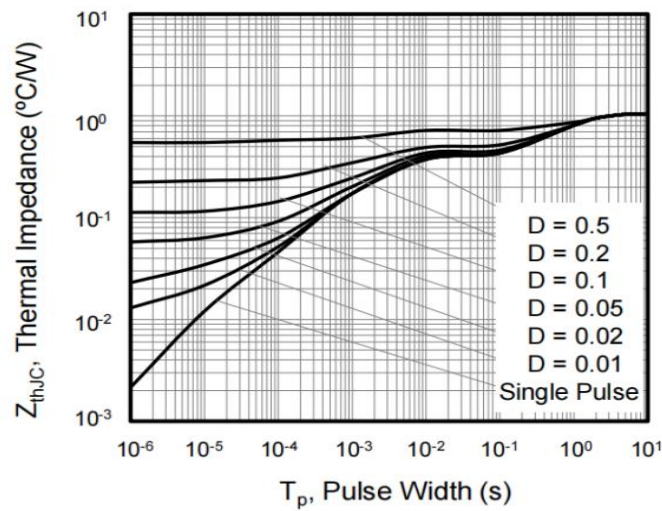


Figure 9. Transient Thermal Impedance



**Test Circuits and Waveforms**

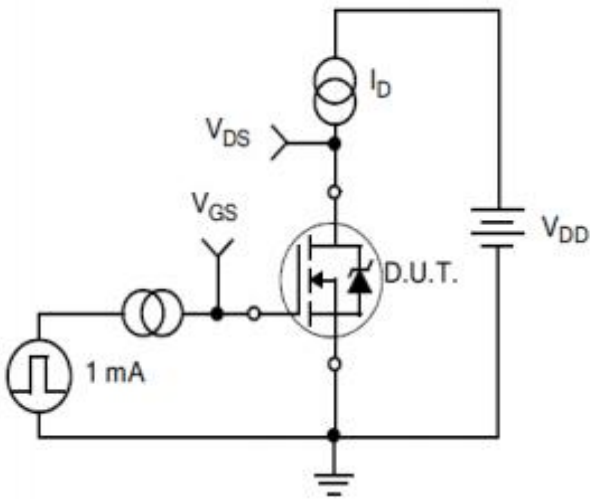


Figure 10.  
Gate Charge Test Circuit

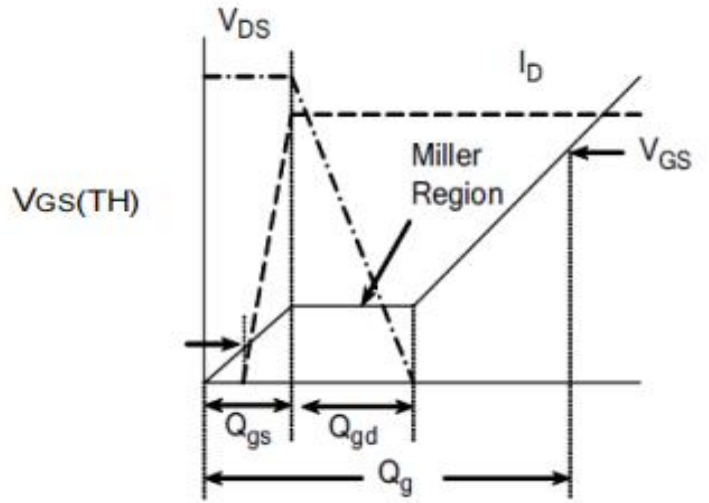


Figure 11.  
Gate Charge Waveform

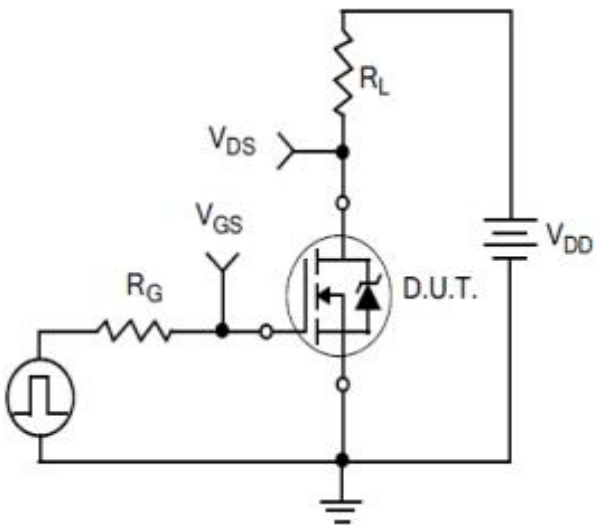


Figure 12.  
Resistive Switching Test Circuit

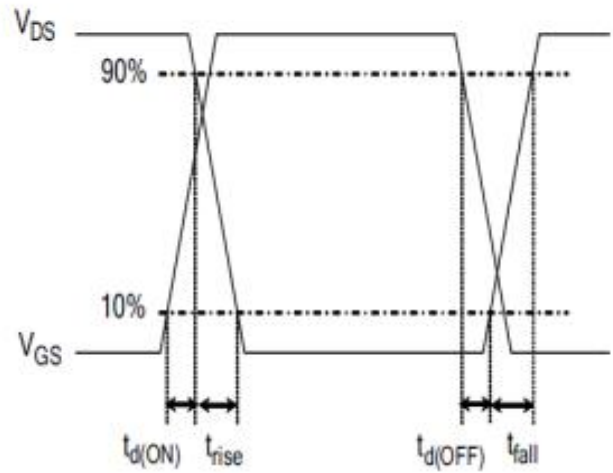


Figure 13.  
Resistive Switching Waveforms



Test Circuits and Waveforms

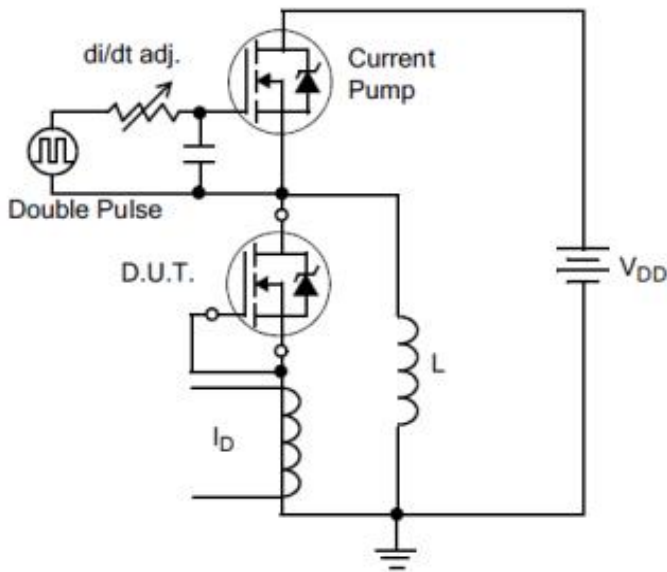


Figure14.Diode Reverse Recovery Test Circuit

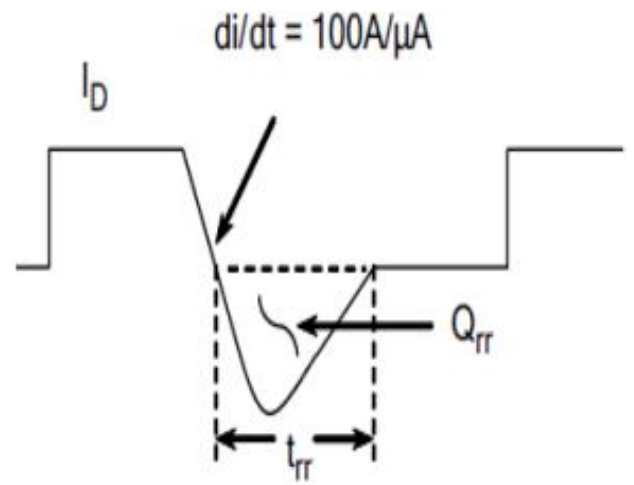


Figure15.Diode Reverse Recovery Waveform

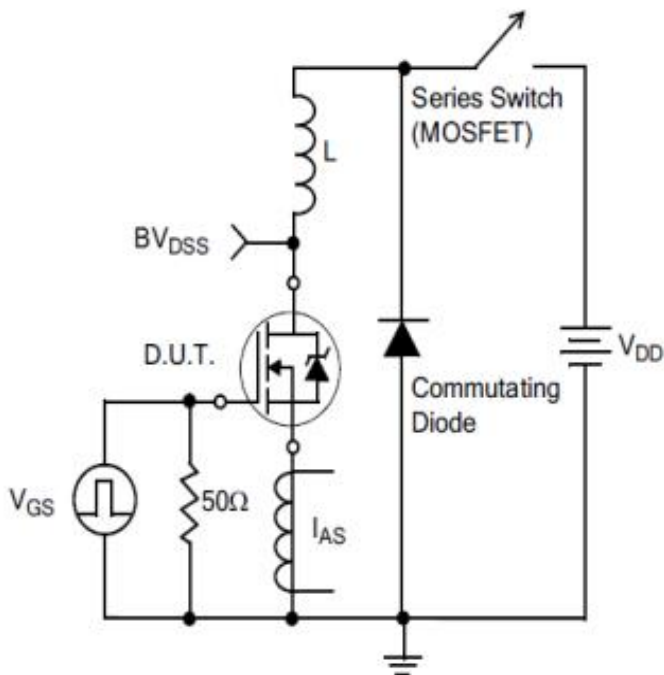
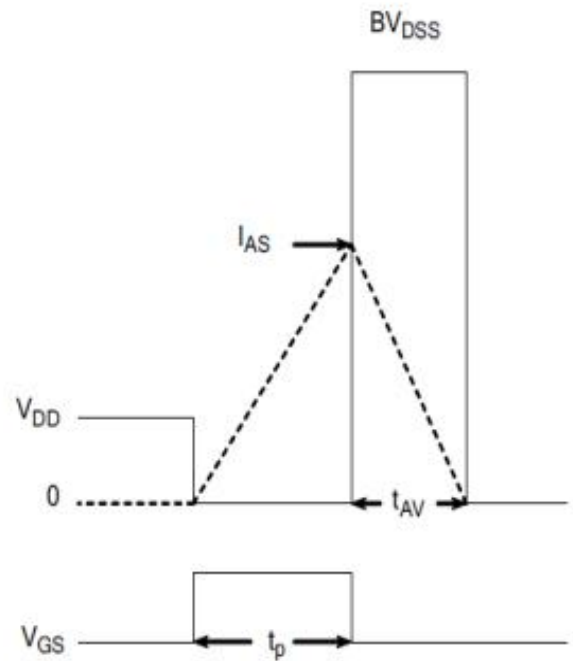


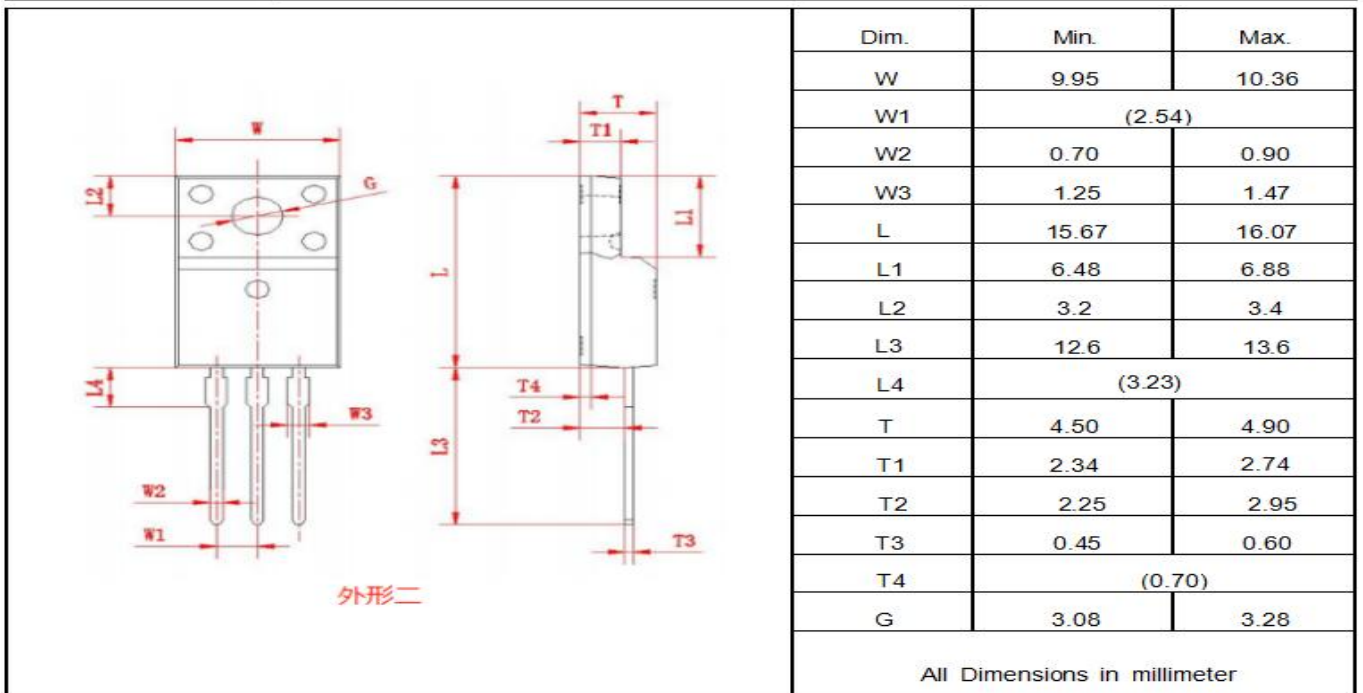
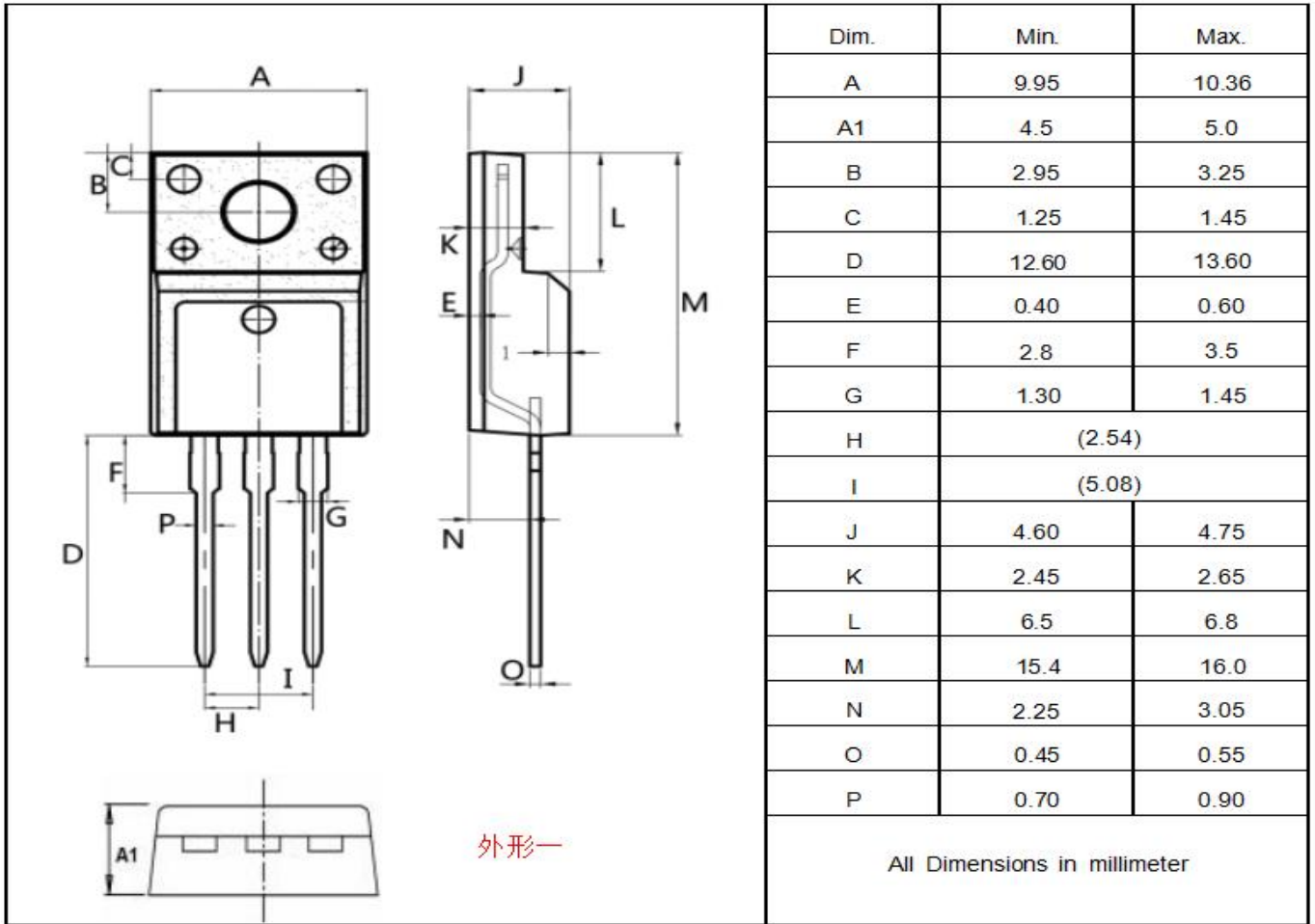
Figure16.Unclamped Inductive Switching Test Circuit



$$E_{AS} = \frac{I_{AS}^2 L}{2}$$

Figure17.Unclamped Inductive Switching Waveforms

Package outline drawing(TO-220F Unit: mm )





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